

Sheet \_1\_ of \_1

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|                                 | U.S. Department of Commerce<br>Patent and Trademark Office | Atty. Docket No. SAR 13774 | Serial No. 09/592,472 |
| INFORMATION DISCLOSURE C        | ITATION  |                            |                       |
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|                                 |  | Applicant Burstyn et al.   |                       |

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